



VALID 2016

The Eighth International Conference on Advances in System Testing and
Validation Lifecycle

ISBN: 978-1-61208-500-5

August 21 - 25, 2016

Rome, Italy

VALID 2016 Editors

Xinli Gu, Huawei Technologies Co., Ltd., USA

Claus-Peter Rückemann, Leibniz Universität Hannover /

Westfälische Wilhelms-Universität Münster /

North-German Supercomputing Alliance (HLRN), Germany